Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/066,545	TSIKOS ET AL.	
Examiner	Art Unit	
Thien M. Le	2876	

	SEAR	CHED	
Class	Subclass	Date	Examiner
235	462.01- 462.47		
	472.01		
	472.02		
	472.03		
	454		
	455		
	494	3/24/2003	LTM
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
235	462 AII				
	472 All	10/22/2005	LTM		

SEARCH NOT (INCLUDING SEARCH S	ES STRATEGY	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR				
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